

1200V, 85A, $V_{ce(on)} = 2.5V$ Typical

Ultra Fast NPT - IGBT®

The Ultra Fast NPT - IGBT® is a new generation of high voltage power IGBTs. Using Non-Punch-Through Technology, the Ultra Fast NPT-IGBT® offers superior ruggedness and ultrafast switching speed.

TO-247 Max TO-264

All Ratings: T_c = 25°C unless otherwise specified.

-55 to 150

300

Features

- Low Saturation Voltage
- Low Tail Current
- RoHS Compliant

- Short Circuit Withstand Rated
- High Frequency Switching
- Ultra Low Leakage Current

Unless stated otherwise, Microsemi discrete IGBTs contain a single IGBT die. This device is recommended for applications such as induction heating (IH), motor control, general purpose inverters and uninterruptible power supplies (UPS).



°C

MAXIMUM RATINGS

 $\mathsf{T}_{\mathsf{J}}, \mathsf{T}_{\mathsf{STG}}$

T,

	5	C	•
Symbol	Parameter	Ratings	Unit
V _{ces}	Collector Emitter Voltage	1200	V
$V_{\rm GE}$	Gate-Emitter Voltage	±30]
I _{C1}	Continuous Collector Current @ T _C = 25°C	170	
I _{C2}	Continuous Collector Current @ T _C = 100°C	85	А
I _{CM}	Pulsed Collector Current ①	340	
SCWT	Short Circuit Withstand Time: V _{CE} = 600V, V _{GE} = 15V, T _C =125°C	10	μs
P _D	Total Power Dissipation @ T _C = 25°C	962	W

STATIC ELECTRICAL CHARACTERISTICS

Operating and Storage Junction Temperature Range

Max. Lead Temp. for Soldering: 0.063" from Case for 10 Sec.

Symbol	Parameter	Min	Тур	Max	Unit
V _{(BR)CES}	Collector-Emitter Breakdown Voltage (V _{GE} = 0V, I _C = 1.0mA)	1200			
V _{GE(TH)}	Gate Threshold Voltage $(V_{CE} = V_{GE}, I_{C} = 2.5 \text{mA}, T_{j} = 25 ^{\circ}\text{C})$	3.5	5.0	6.5	Volts
V _{CE(ON)}	Collector-Emitter On Voltage ($V_{GE} = 15V$, $I_{C} = 85A$, $T_{j} = 25^{\circ}C$)		2.5	3.2	
	Collector-Emitter On Voltage ($V_{GE} = 15V$, $I_{C} = 85A$, $T_{j} = 125^{\circ}C$)		3.3		
	Collector-Emitter On Voltage (V _{GE} = 15V, I _C = 170A, T _j = 25°C)		3.5		
I _{CES}	Collector Cut-off Current (V _{CE} = 1200V, V _{GE} = 0V, T _j = 25°C) ②		10	1000	μA
	Collector Cut-off Current (V _{CE} = 1200V, V _{GE} = 0V, T _j = 125°C) ②		100		
I _{GES}	Gate-Emitter Leakage Current (V _{GE} = ±20V)			±250	nA

CAUTION: These Devices are Sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

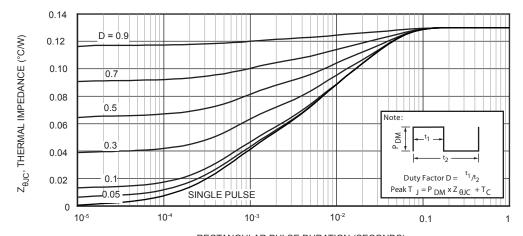
Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
C _{ies}	Input Capacitance	Capacitance		8400		
C _{oes}	Output Capacitance	$V_{GE} = 0V, V_{CE} = 25V$		725		pF
C _{res}	Reverse Transfer Capacitance	f = 1MHz		190		
V_{GEP}	Gate to Emitter Plateau Voltage	Cata Charra		7.5		V
Q _g 3	Total Gate Charge	Gate Charge		490	660	
Q_{ge}	Gate-Emitter Charge	V _{GE} = 15V		60	85	 0
Q_{gc}	Gate- Collector Charge	V _{CE} = 600V I _C = 85A		230	320	nC
t _{d(on)}	Turn-On Delay Time	Inductive Switching (25°C)		43		
t _r	Current Rise Time	V _{CC} = 600V		70		
t _{d(off)}	Turn-Off Delay Time	V _{GE} = 15V		300		ns
t _f	Current Fall Time	I _C = 85A		85		[
E _{on2} 5	Turn-On Switching Energy	$R_{G} = 4.3 \Omega^{4}$		6000	9000	1
E _{off}	Turn-Off Switching Energy	T _{,j} = +25°C		3800	5700	μJ
t _{d(on)}	Turn-On Delay Time	Inductive Switching (125°C)		43		
t _r	Current Rise Time	V _{CC} = 600V		70		20
t _{d(off)}	Turn-Off Delay Time	V _{GE} = 15V		350		ns
t _r	Current Fall Time	I _C = 85A		95		
E _{on2}	Turn-On Switching Energy	$R_{G} = 4.3 \Omega^{4}$		7800	11,700	1
E _{off}	Turn-Off Switching Energy	T _J = +125°C		4900	7350	μJ

THERMAL AND MECHANICAL CHARACTERISTICS

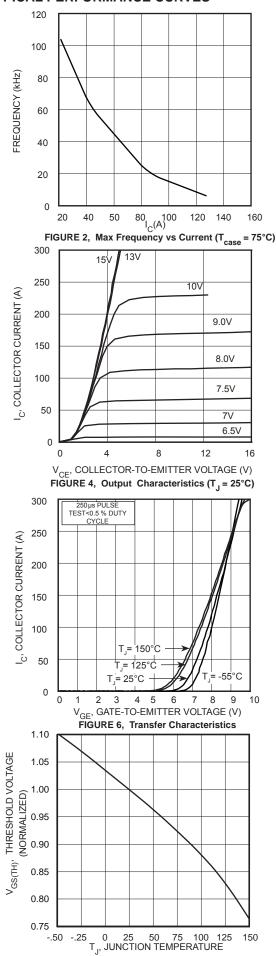
Symbol	Characteristic		Min	Тур	Max	Unit
R _{eJC}	Junction to Case Thermal Resistance (IGBT)				.13	°C/W
$R_{\theta JA}$	Junction to Ambient Thermal Resistance				40	C/VV
W _T	Package Weight	B2		.22		oz
				6		g
		L		.36		oz
				10		g

- 1 Repetitive Rating: Pulse width and case temperature limited by maximum junction temperature.
- 2 Pulse test: Pulse Width < $380\mu s$, duty cycle < 2%.
- 3 See Mil-Std-750 Method 3471.
- 4 $R_{\rm g}$ is external gate resistance, not including internal gate resistance or gate driver impedance. (MIC4452)
- 5 E_{onz} is the clamped inductive turn on energy that includes a commutating diode reverse recovery current in the IGBT turn on energy loss. A combi device is used for the clamping diode.
- 6 E_{off} is the clamped inductive turn-off energy measured in accordance with JEDEC standard JESD24-1.

Microsemi reserves the right to change, without notice, the specifications and information contained herein.



RECTANGULAR PULSE DURATION (SECONDS)
Figure 1, Maximum Effective Transient Thermal Impedance, Junction-To-Case vs Pulse Duration



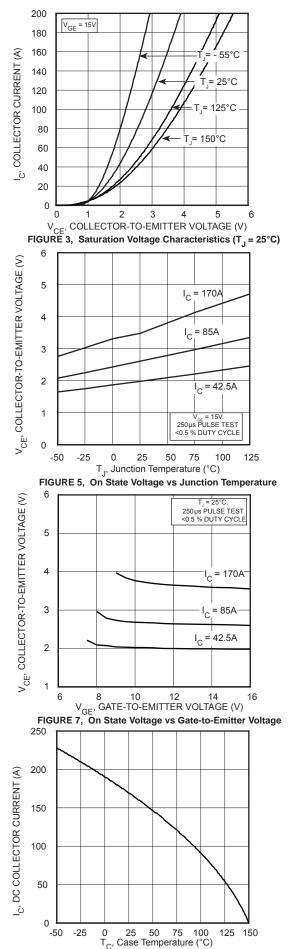
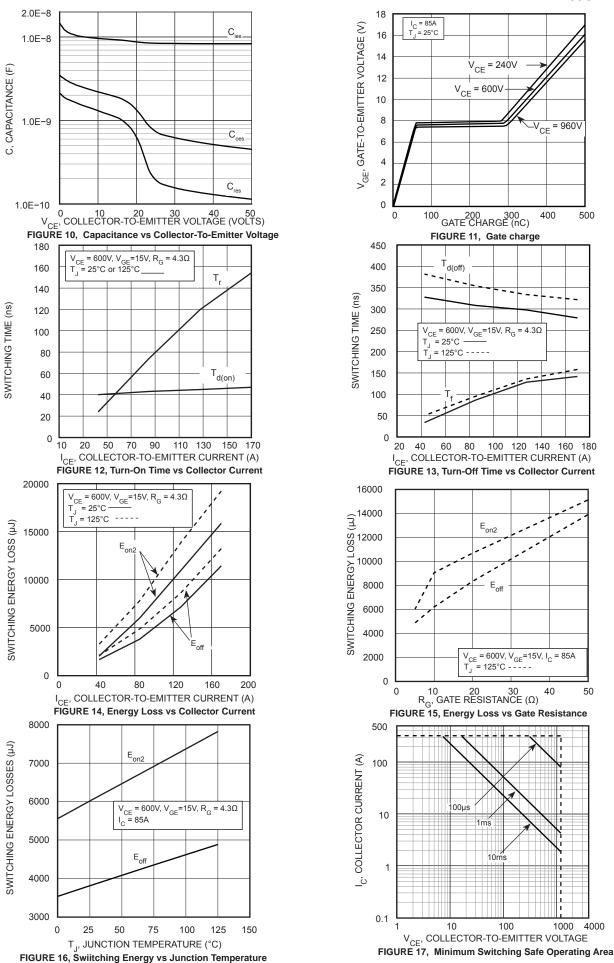


FIGURE 9, DC Collector Current vs Case Temperature

FIGURE 8, Threshold Voltage vs Junction Temperature



8-2012

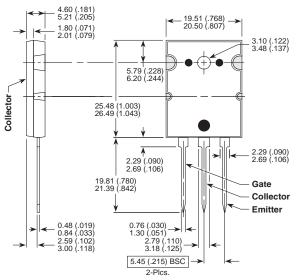
Rev A

T-MAX™ (B2) Package Outline

4.69 (.185) 5.31 (.209) 1.49 (.059) 2.49 (.098) 20.80 (.819) 21.46 (.845) 4.50 (.177) Max. 2.87 (.113) 3.12 (.123) 1.65 (.065) 2.13 (.084) 20.32 (.800) 1.40 (.055) 2.59 (.102) 5.45 (.215) BSC 2-Pics.

These dimensions are equal to the TO-247 without the mounting hole. Dimensions in Millimeters and (Inches)

TO-264 (L) Package Outline



Dimensions in Millimeters and (Inches)

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